

N-Channel 80-V and 90-V (D-S) MOSFETS

PRODUCT SUMMARY				
Part Number	$V_{(BR)DSS}$ Min (V)	$r_{DS(on)}$ Max (Ω)	$V_{GS(th)}$ (V)	I_D (A)
2N6661	90	4 @ $V_{GS} = 10$ V	0.8 to 2	0.9
VN88AFD	80	4 @ $V_{GS} = 10$ V	0.8 to 2.5	1.29

FEATURES

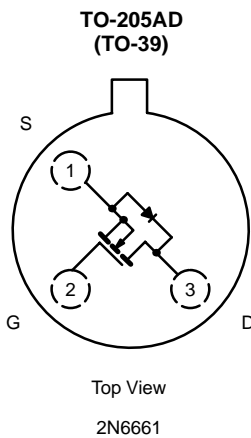
- Low On-Resistance: 3.6 Ω
- Low Threshold: 1.6 V
- Low Input Capacitance: 35 pF
- Fast Switching Speed: 6 ns
- Low Input and Output Leakage

BENEFITS

- Low Offset Voltage
- Low-Voltage Operation
- Easily Driven Without Buffer
- High-Speed Circuits
- Low Error Voltage

APPLICATIONS

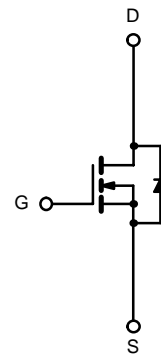
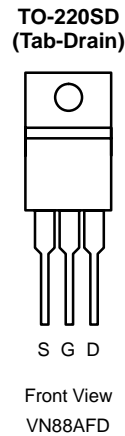
- Direct Logic-Level Interface: TTL/CMOS
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc.
- Battery Operated Systems
- Solid-State Relays



Device Marking
Side View

2N6661
"S" flxxyy

"S" = Siliconix Logo
f = Factory Code
ll = Lot Traceability
xyyy = Date Code



Device Marking
Front View

VN88AFD
"S" xxyy

"S" = Siliconix Logo
xyyy = Date Code

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	2N6661	VN88AFD	Unit
Drain-Source Voltage	V_{DS}	90	80	V
Gate-Source Voltage	V_{GS}	± 20	± 30	
Continuous Drain Current ($T_J = 150^\circ\text{C}$)	I_D	$T_C = 25^\circ\text{C}$	0.9	A
		$T_C = 100^\circ\text{C}$	0.7	
Pulsed Drain Current ^a	I_{DM}	± 3	± 3	
Power Dissipation	P_D	$T_C = 25^\circ\text{C}$	6.25	W
		$T_C = 100^\circ\text{C}$	2.5	
Thermal Resistance, Junction-to-Ambient ^b	R_{thJA}	170		$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case	R_{thJC}		8.3	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150		$^\circ\text{C}$

Notes

- Pulse width limited by maximum junction temperature.
- This parameter not registered with JEDEC.

SPECIFICATIONS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)									
Parameter	Symbol	Test Conditions	Typ ^a	Limits				Unit	
				2N6661		VN88AFD			
				Min	Max	Min	Max		
Static									
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 10\ \mu\text{A}$	125	90		80		V	
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 1\ \text{mA}$		0.8	2	0.8	2.5		
			$T_J = -55^\circ\text{C}$	1.8					
			$T_J = 125^\circ\text{C}$	1.3					
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 15\text{ V}$			± 100		± 100	nA	
			$T_J = 125^\circ\text{C}$			± 500			± 500
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 90\text{ V}, V_{GS} = 0\text{ V}$			10			μA	
			$V_{DS} = 80\text{ V}, V_{GS} = 0\text{ V}$				10		
			$V_{DS} = 0.8 \times V_{(BR)DSS}, V_{GS} = 0\text{ V}$				1		
			$T_J = 125^\circ\text{C}$			500			500
On-State Drain Current ^b	$I_{D(on)}$	$V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}$	1.8	1.5				A	
			$V_{DS} = 10\text{ V}, V_{GS} = 10\text{ V}$	1.8			1.5		
Drain-Source On-Resistance ^b	$r_{DS(on)}$	$V_{GS} = 5\text{ V}, I_D = 0.3\text{ A}$	3.8		5.3		5.6	Ω	
			$V_{GS} = 10\text{ V}, I_D = 1\text{ A}$	3.6		4			4
			$T_J = 125^\circ\text{C}^d$	6.7		9			8
Forward Transconductance ^b	g_{fs}	$V_{DS} = 10\text{ V}, I_D = 0.5\text{ A}$	350	170		170		mS	
Diode Forward Voltage	V_{SD}	$I_S = 0.86\text{ A}, V_{GS} = 0\text{ V}$	0.9					V	
Dynamic									
Input Capacitance	C_{iss}	$V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$	35		50		50	pF	
Output Capacitance	C_{oss}		15		40		40		
Reverse Transfer Capacitance	C_{rss}		2		10		10		
Drain-Source Capacitance	C_{ds}		30		40				
Switching^c									
Turn-On Time	t_{ON}	$V_{DD} = 25\text{ V}, R_L = 23\ \Omega$ $I_D \cong 1\text{ A}, V_{GEN} = 10\text{ V}$ $R_G = 25\ \Omega$	6		10		15	ns	
Turn-Off Time	t_{OFF}		8		10		15		

Notes

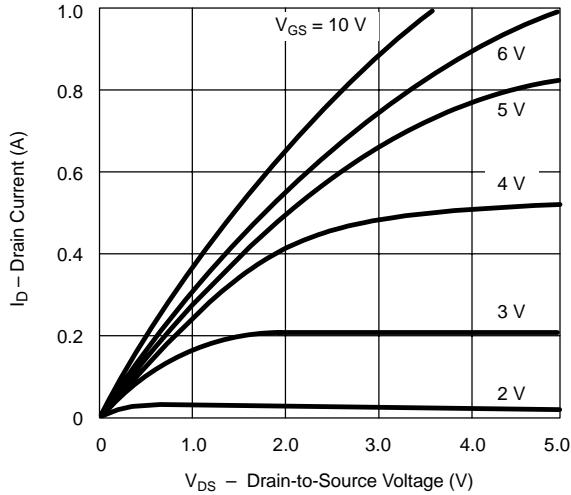
- For DESIGN AID ONLY, not subject to production testing.
- Pulse test: $PW \leq 300\ \mu\text{s}$ duty cycle $\leq 2\%$.
- Switching time is essentially independent of operating temperature.
- This parameter not registered with JEDEC.

VNDQ09

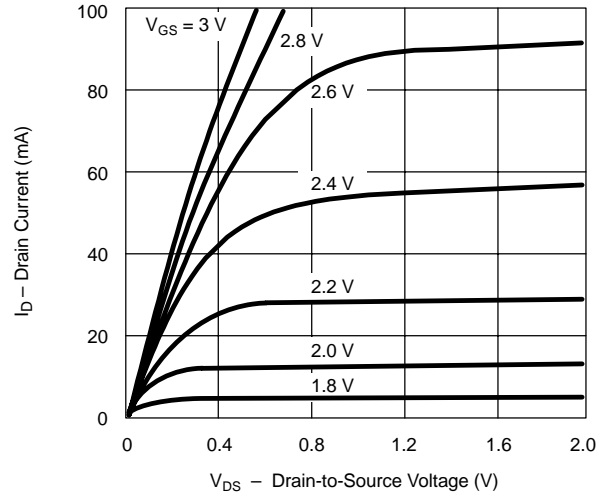


TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

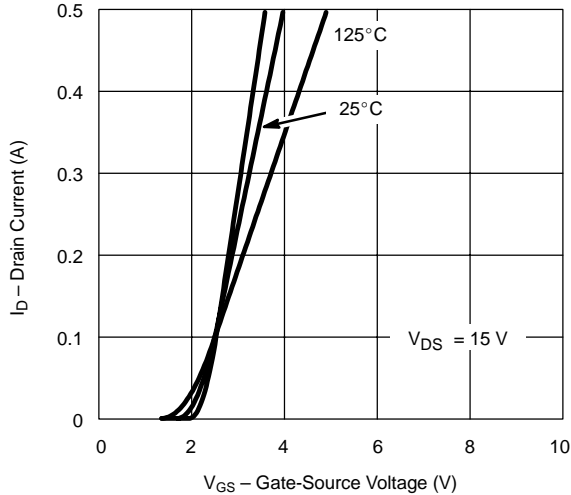
Ohmic Region Characteristics



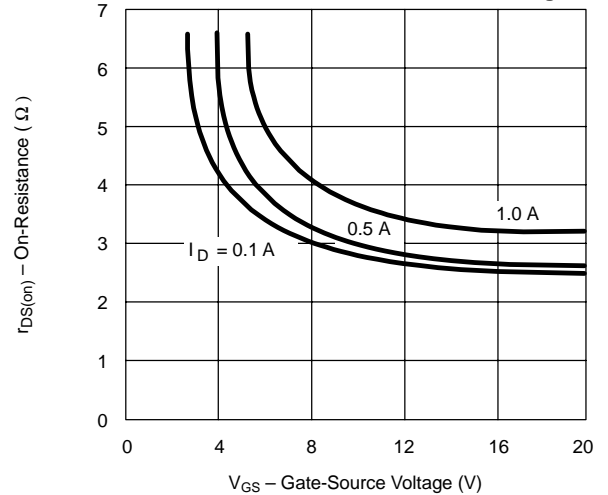
Output Characteristics for Low Gate Drive



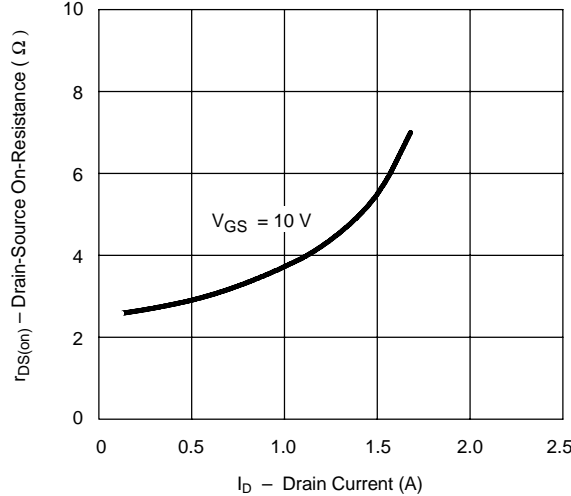
Transfer Characteristics



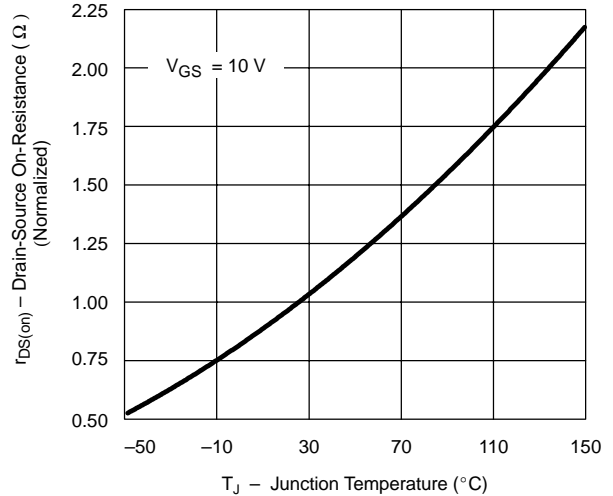
On-Resistance vs. Gate-to-Source Voltage



On-Resistance vs. Drain Current



Normalized On-Resistance vs. Junction Temperature





TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

